

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	18	((("5973785") or ("5835220") or ("5774222") or ("5608527") or ("5479252") or ("5386317") or ("5333052") or ("5046847")).PN.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/07/28 14:32
L2	1124123	(determin\$5 or detect\$5 or measur\$5 or inspect\$5 or monitor\$5 or evaluat\$5 or calculat\$5) near5 (sample or object or wafer or surface)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/28 14:16
L3	25509	(image or imaging) with (compar\$5 with (reference or baseline or predetermin\$5))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/28 10:25
L4	2692	((reduce or reducing or adjust or adjusting or control or controlling) near3 amplitude) near10 (light beam)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/28 11:40
L5	0	1 and 4	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/28 10:27
L6	18	2 and 3 and 4	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/28 10:27
L8	44871	((reduce or reducing or adjust or adjusting or control or controlling or change or changing) near3 (amplitude or intensity)) near10 (light or beam)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/28 11:42
L9	574	2 and 3 and 8	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/28 11:42
L10	4613	((reduce or reducing or adjust or adjusting or control or controlling or change or changing) near3 amplitude) near10 (light or beam)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/28 12:20

L11	52	2 and 3 and 10	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/28 11:42
L12	274959	(determin\$5 or detect\$5 or measur\$5 or inspect\$5 or monitor\$5 or evaluat\$5 or calculat\$5) near5 (defect or particle or abnormal\$5)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/28 12:19
L13	300	10 and 12	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/28 12:20
L14	115	13 and polariz\$5	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/28 12:19
L16	56473	((determin\$5 or detect\$5 or measur\$5 or inspect\$5 or monitor\$5 or evaluat\$5 or calculat\$5) near5 (defect or particle or abnormal\$5)) with (sample or object or wafer or surface)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/28 12:19
L17	121	10 and 16	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/28 12:21
L20	470	((reduce or reducing or adjust or adjusting or control or controlling or change or changing) near3 amplitude) near10 ((reflect\$5 or diffract\$5) near3 (light or beam))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/28 14:41
L21	18	20 and 16	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/28 12:21
L25	7	2 and 20 and 3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/28 14:23
L26	10	20 and 3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/28 15:01

L27	318	(amplitude near3 ((reflect\$5 or diffract\$5) near2 light)) near8 (adjust\$5 or control\$5 or decrease\$5 or change\$5)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/28 14:32
L28	13	L27 and image and (compare\$5 with (reference or baseline or predetermined\$5)) and @ad<="19980918"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/28 14:34
L29	699	((reduce\$5 or adjust\$5 or control\$5 or change\$5 or decrease\$5) near3 amplitude) near10 ((reflect\$5 or diffract\$5) near3 (light or beam))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/28 14:42
L31	324	2 and 29	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/28 15:26
L32	9	31 and 3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/28 15:26